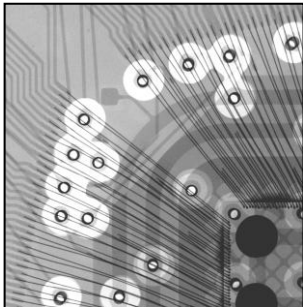


## Application:

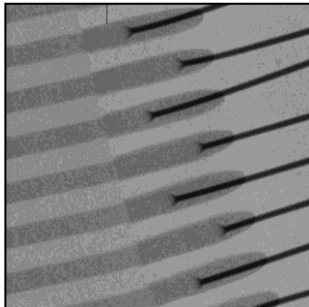
- Production Line – 2D Inspection
  - Bonding Wire (Au/Cu), Bump / Void Inspection
- Quality Assurance – 3D CT Analysis
  - TSV, Bump Delamination, Multi-Chip Packaging
  - 3D Packaging

## Systems:

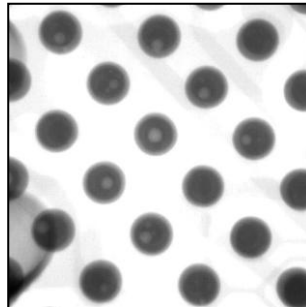
- X-eye SF160A (2D) / SF160ACT (3D)
- X-eye 5000BTS
- X-eye 3000A
- X-eye Micro CT



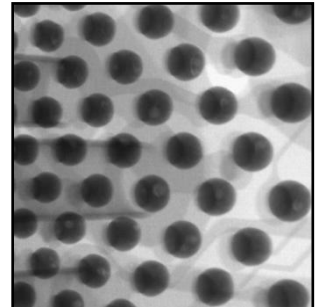
Bonding Wire (2D)



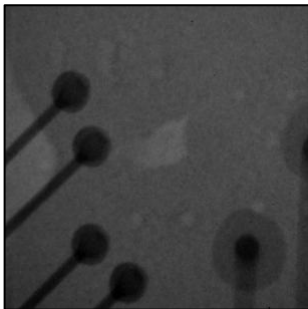
Bonding Wire (2D)



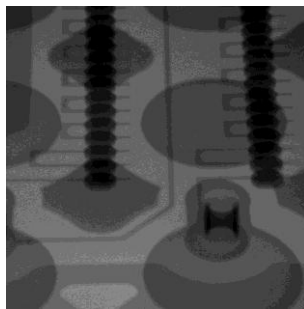
Bump Void



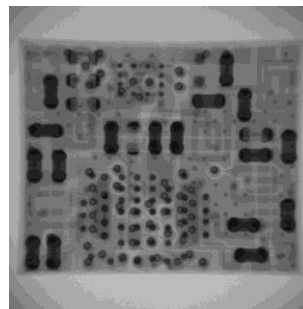
Bump Void – Tilt View



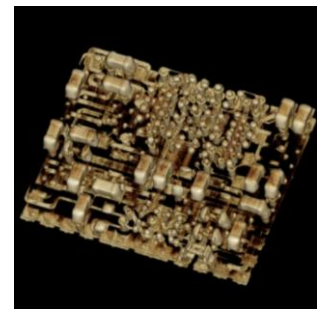
Epoxy Void



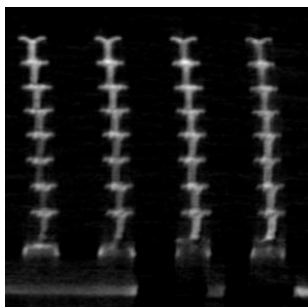
Bump



SiP – 2D



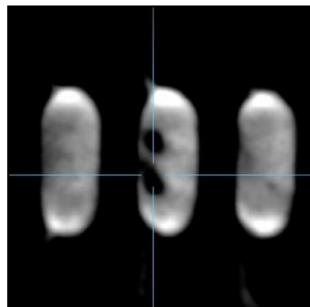
SiP – 3D CT



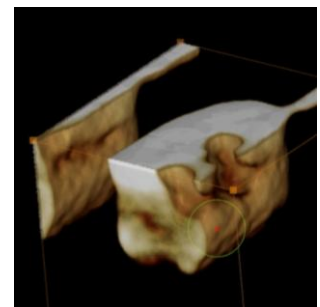
TSV Stack – Slice View



TSV Stack – 3D View



Cu Pillar – Slice View



Cu Pillar – 3D View